

T-39-11

**MOTOROLA**  
**SEMICONDUCTOR**  
TECHNICAL DATA

*Designer's Data Sheet*  
**Power Field Effect Transistor**  
**N-Channel Enhancement-Mode**  
**Silicon Gate TMOS**

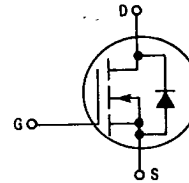
These TMOS Power FETs are designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds — Switching Times Specified at 100°C
- Designer's Data —  $I_{DSS}$ ,  $V_{DS(on)}$ ,  $V_{GS(th)}$  and SOA Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads



**MTM3N60**  
**MTP3N55**  
**MTP3N60**

TMOS POWER FETs  
3 AMPERES  
 $r_{DS(on)} = 2.5$  OHMS  
550 and 600 VOLTS

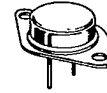


**MAXIMUM RATINGS**

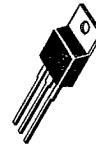
Rating	Symbol	MTP3N55	MTM3N60 MTP3N60	Unit
		Drain-Source Voltage	$V_{DSS}$	
Drain-Gate Voltage ( $R_{GS} = 1 M\Omega$ )	$V_{DGR}$	550	600	Vdc
Gate-Source Voltage — Continuous — Non-repetitive ( $t_p \leq 50 \mu s$ )	$V_{GS}$	$\pm 20$		Vdc
	$V_{GSM}$	$\pm 40$		Vpk
Drain Current Continuous Pulsed	$I_D$	3		Adc
	$I_{DM}$	10		
Total Power Dissipation @ $T_C = 25^\circ C$ Derate above 25°C	$P_D$	75		Watts
		0.6		W/°C
Operating and Storage Temperature Range	$T_J, T_{stg}$	-65 to 150		°C

**THERMAL CHARACTERISTICS**

Thermal Resistance Junction to Case	$R_{\theta JC}$	1.67	°C/W	
		Junction to Ambient TO-204 TO-220		$R_{\theta JA}$
62.5				
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	$T_L$	275		°C



MTM3N60  
CASE 1-06  
TO-204AA



MTP3N55  
MTP3N60  
CASE 221A-04  
TO-220AB

**Designer's Data for "Worst Case" Conditions** — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

MOTOROLA TMOS POWER MOSFET DATA

**ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>				
Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0, I <sub>D</sub> = 0.25 mA)	V <sub>(BR)DSS</sub>	550	—	Vdc
MTP3N55 MTM/MTP3N60		600	—	
Zero Gate Voltage Drain Current (V <sub>DS</sub> = Rated V <sub>DSS</sub> , V <sub>GS</sub> = 0) (V <sub>DS</sub> = 0.8 Rated V <sub>DSS</sub> , V <sub>GS</sub> = 0, T <sub>J</sub> = 125°C)	I <sub>DSS</sub>	—	0.2 1	mAdc
Gate-Body Leakage Current, Forward (V <sub>GSSF</sub> = 20 Vdc, V <sub>DS</sub> = 0)	I <sub>GSSF</sub>	—	100	nAdc
Gate-Body Leakage Current, Reverse (V <sub>GSR</sub> = 20 Vdc, V <sub>DS</sub> = 0)	I <sub>GSSR</sub>	—	100	nAdc

**ON CHARACTERISTICS\***

Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 1 mA) T <sub>J</sub> = 100°C	V <sub>GS(th)</sub>	2 1.5	4.5 4	Vdc
Static Drain-Source On-Resistance (V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 1.5 Adc)	r <sub>DS(on)</sub>	—	2.5	Ohms
Drain-Source On-Voltage (V <sub>GS</sub> = 10 V) (I <sub>D</sub> = 3 Adc) (I <sub>D</sub> = 1.5 Adc, T <sub>J</sub> = 100°C)	V <sub>DS(on)</sub>	—	9 7.5	Vdc
Forward Transconductance (V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1.5 A)	g <sub>FS</sub>	1.5	—	mhos

**DYNAMIC CHARACTERISTICS**

Input Capacitance	(V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0, f = 1 MHz) See Figure 11	C <sub>iss</sub>	—	1000	pF
Output Capacitance		C <sub>oss</sub>	—	300	
Reverse Transfer Capacitance		C <sub>rss</sub>	—	80	

**SWITCHING CHARACTERISTICS\* (T<sub>J</sub> = 100°C)**

Turn-On Delay Time	(V <sub>DD</sub> = 25 V, I <sub>D</sub> = 0.5 Rated I <sub>D</sub> R <sub>gen</sub> = 50 ohms) See Figures 9, 13 and 14	t <sub>d(on)</sub>	—	50	ns
Rise Time		t <sub>r</sub>	—	100	
Turn-Off Delay Time		t <sub>d(off)</sub>	—	180	
Fall Time		t <sub>f</sub>	—	80	
Total Gate Charge	(V <sub>DS</sub> = 0.8 Rated V <sub>DSS</sub> , I <sub>D</sub> = Rated I <sub>D</sub> , V <sub>GS</sub> = 10 V) See Figure 12	Q <sub>g</sub>	16 (Typ)	18	nC
Gate-Source Charge		Q <sub>gs</sub>	8 (Typ)	—	
Gate-Drain Charge		Q <sub>gd</sub>	8 (Typ)	—	

**SOURCE DRAIN DIODE CHARACTERISTICS\***

Forward On-Voltage	(I <sub>S</sub> = Rated I <sub>D</sub> V <sub>GS</sub> = 0)	V <sub>SD</sub>	1.1 (Typ)	—	Vdc
Forward Turn-On Time		t <sub>on</sub>	Limited by stray inductance		
Reverse Recovery Time		t <sub>rr</sub>	165 (Typ)	—	ns

**INTERNAL PACKAGE INDUCTANCE (TO-204)**

Internal Drain Inductance (Measured from the contact screw on the header closer to the source pin and the center of the die)	L <sub>d</sub>	6 (Typ)	—	nH
Internal Source Inductance (Measured from the source pin, 0.25" from the package to the source bond pad)	L <sub>s</sub>	12.5 (Typ)	—	nH

**INTERNAL PACKAGE INDUCTANCE (TO-220)**

Internal Drain Inductance (Measured from the contact screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die)	L <sub>d</sub>	3.5 (Typ) 4.5 (Typ)	—	nH
Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad.)	L <sub>s</sub>	7.5 (Typ)	—	nH

\*Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

TYPICAL ELECTRICAL CHARACTERISTICS

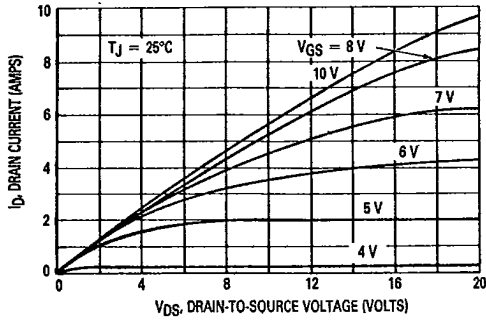


Figure 1. On-Region Characteristics

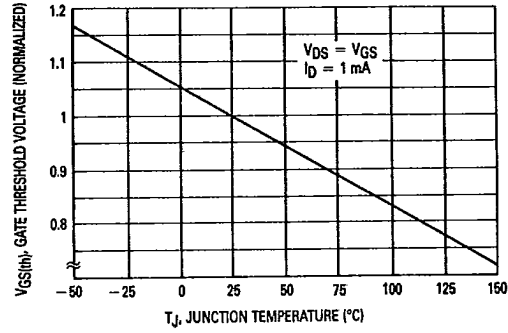


Figure 2. Gate-Threshold Voltage Variation With Temperature

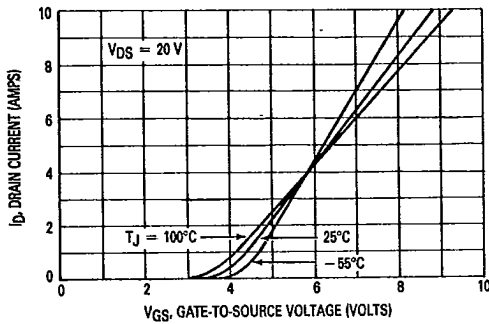


Figure 3. Transfer Characteristics

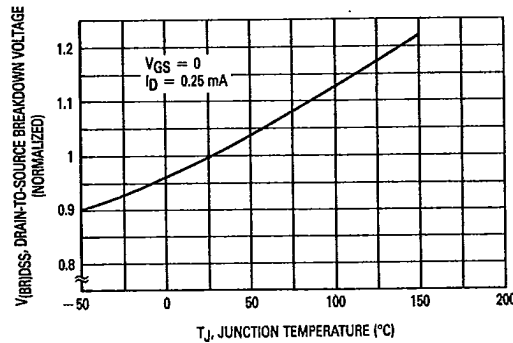


Figure 4. Breakdown Voltage Variation With Temperature

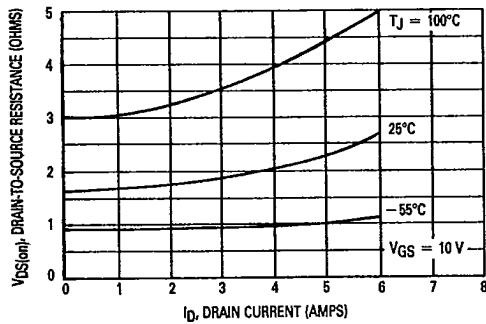


Figure 5. On-Resistance versus Drain Current

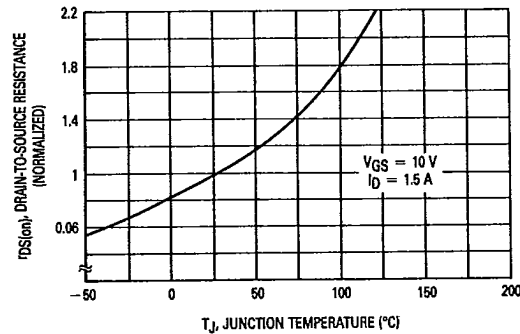


Figure 6. On-Resistance Variation With Temperature

SAFE OPERATING AREA INFORMATION

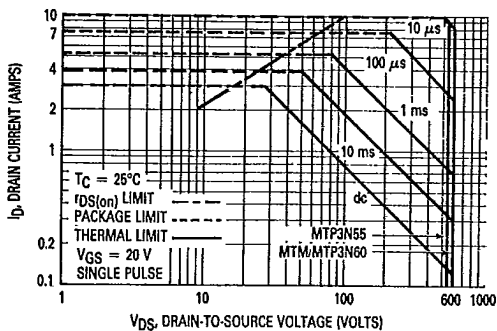


Figure 7. Maximum Rated Forward Biased Safe Operating Area

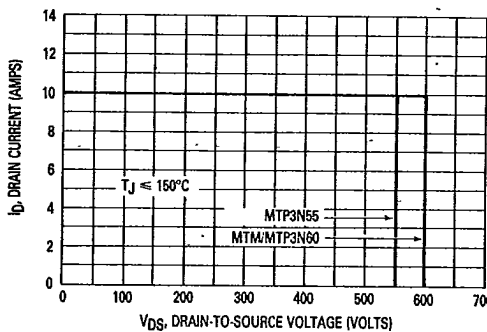


Figure 8. Maximum Rated Switching Safe Operating Area



FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current,  $I_{DM}$  and the breakdown voltage,  $V_{(BR)DSS}$ . The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_J(max) - T_C}{R_{\theta JC}}$$

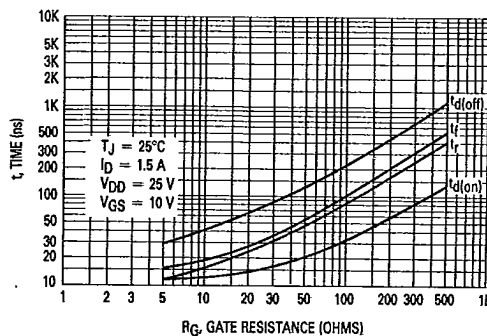


Figure 9. Resistive Switching Time Variation versus Gate Resistance

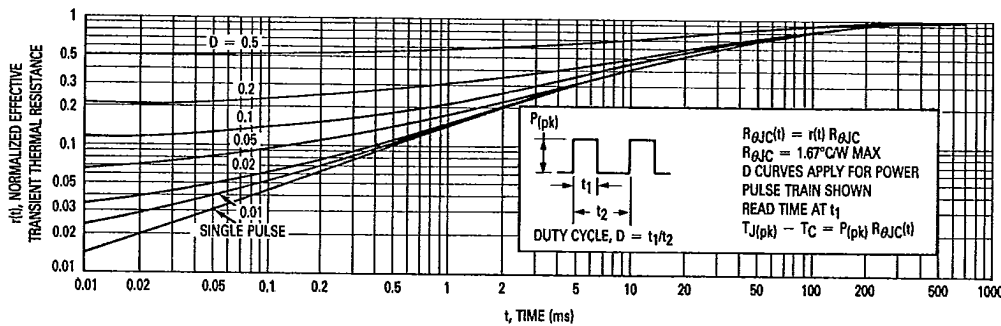


Figure 10. Thermal Response

MOTOROLA TMOS POWER MOSFET DATA

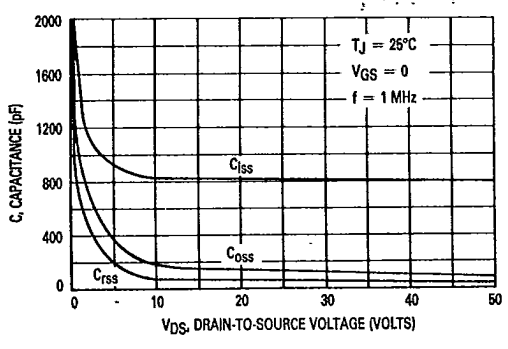


Figure 11. Capacitance Variation

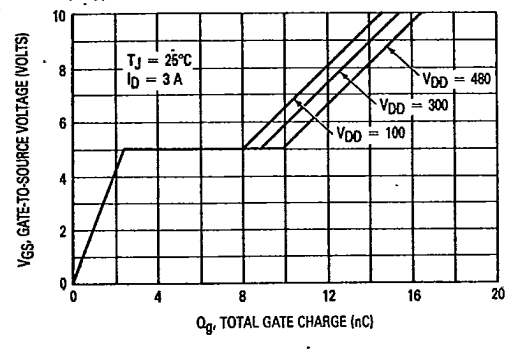


Figure 12. Gate Charge versus Gate-to-Source Voltage

RESISTIVE SWITCHING

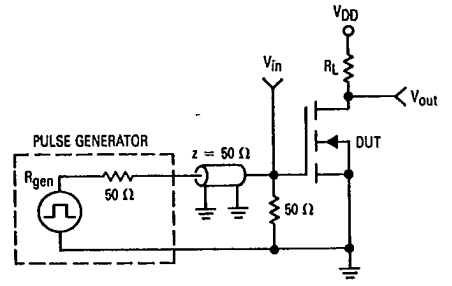


Figure 13. Switching Test Circuit

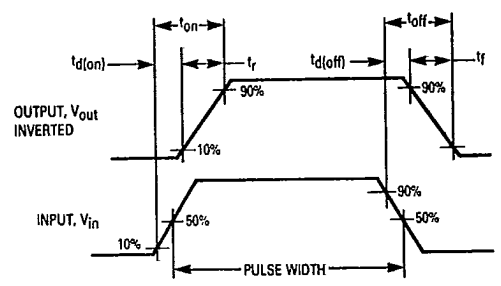


Figure 14. Switching Waveforms

OUTLINE DIMENSIONS

**CASE 1-06  
TO-204AA**

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	—	29.27	—	1.150
B	—	21.08	—	0.830
C	6.35	8.15	0.250	0.325
D	0.97	1.08	0.038	0.043
E	1.40	1.77	0.055	0.070
F	30.15 BSC	—	1.187 BSC	—
G	—	10.92 BSC	—	0.430 BSC
H	—	5.48 BSC	—	0.215 BSC
J	—	16.83 BSC	—	0.665 BSC
K	11.18	12.19	0.440	0.480
Q	3.94	4.19	0.151	0.165
R	—	26.67	—	1.050
U	4.83	5.33	0.190	0.210
V	3.84	4.19	0.151	0.165

NOTES:  
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982  
 2. CONTROLLING DIMENSION INCH.  
 3. ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO 204AA OUTLINE SHALL APPLY.

STYLE 3:  
 PIN 1, GATE  
 2, SOURCE  
 CASE DRAIN

**CASE 221A-04  
TO-220AB**

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	14.48	15.25	0.570	0.600
B	9.08	10.78	0.360	0.420
C	6.77	8.82	0.260	0.350
D	6.64	8.88	0.265	0.350
F	3.81	3.73	0.150	0.147
G	3.42	3.56	0.135	0.140
H	2.80	2.83	0.110	0.112
J	6.38	6.50	0.250	0.256
K	12.70	14.77	0.500	0.582
L	1.15	1.28	0.045	0.050
M	4.83	5.33	0.190	0.210
Q	3.54	3.54	0.140	0.140
R	2.04	2.73	0.080	0.110
S	1.15	1.28	0.045	0.050
T	3.81	4.07	0.150	0.160
U	6.10	1.27	0.240	0.050
V	1.15	—	0.045	—
Z	—	2.04	—	0.080

NOTES:  
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.  
 2. CONTROLLING DIMENSION INCH.  
 3. DIM Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

STYLE 5:  
 PIN 1, GATE  
 2, DRAIN  
 3, SOURCE  
 4, DRAIN

MOTOROLA TMOS POWER MOSFET DATA